

Prediction of Epileptic Seizure Using EEG Signal Processing By MLPNN and SVM Classifiers

Arun Kumar*, Manisha Chandani**

Bhilai Institute of Technology, Durg *

Bhilai Institute of Technology, Durg**

Email: arun.kumar@bitdurg.ac.in*, chandani.manisha09@gmail.com**

ABSTRACT

Electroencephalogram signals (EEG) have always been used in medical diagnosis. Evaluation of the statistical characteristics of EEG signals is actually the foundation of all brain signal processing methods. Since the correct prediction of disease status is of utmost importance, the goal is to use those models that have minimum error and maximum reliability. In an automatic epileptic seizure detection system, we should be able to distinguish between EEG signals before, during and after seizure. Extracting useful characteristics from EEG data can greatly increase the classification accuracy. In this new approach first parse EEG signals to sub-bands in different categories with the help of discrete wavelet transform (DWT) and then we derive statistical features such as Mean, Median, Standard Deviation, Kurtosis, Entropy, Skewness for each sub-band. These features, extracted from details and approximation coefficients of DWT sub-bands, are used as input to Principal Component Analysis (PCA). The classification is based on reducing the feature dimension using PCA and deriving the Support Vector Machine (SVM) and neural network analysis (NNA). In classification of normal and epileptic, results obtained exhibited an accuracy of 100% by applying NNA and 99% by SVM it has been found that the computation time of NNA classifier is lesser than SVM to provide 100% accuracy.

Keywords — Discrete Wavelet Transforms (DWT), Accuracy, Electroencephalogram Signals (EEG), Multilayer Perceptron (MLP), Epileptic Seizure. Support Vector Machine (SVM).

1. INTRODUCTION

Epilepsy is one of the most prevalent neurological disorders among people [1]. It is estimated that 5 people are afflicted with epilepsy among each 1000 people. Epilepsy could be defined as a sudden change in the intracellular and extracellular potential difference. This definition implies that the type of neuron determines clinical demonstrations [2]. The automatic diagnosis of epileptic convulsions has attracted the attention of clinicians and engineers since 1970. The automatic prediction of seizures is useful in drug delivery systems and neural stimulation simulation devices [3,4]. An important issue in predicting epileptic convulsions is that they are predictable through analyzing the changes in the features of EEG signals that happen before the occurrence of seizures [5]. Epileptic seizures prediction needs further analysis due to the following reasons [6]:

1. Generally, their results are not repeatable. In other words, their confidence rate is not certain.
2. The dependence of the result on sensitivity and inaccurate prediction rate is not taken into account.
3. Their efficiency is not mostly acceptable and has a high acceptance and rejection rate.

2. MATERIAL AND METHOD

In an automatic epileptic convulsion detection system, a distinction should be made between the pre-convulsion, during convulsion, and post-convulsion EEG signals. Then, they should be analyzed [7]. Some studies focused on single-channel EEG signals, while some others focused on multi-channel recorded EEG signals [8]. This paper studied the epileptic and healthy signals of R. G. Andrzejak database from the University of Bonn [9]. The data relate to three different categories: normal situation of the patient, pre-seizure and seizure.

The collected EEG signals include 5 categories which, respectively, are called (A,B,C,D,E). Each of these categories includes 100 single-channel signals with a length of 26.3 seconds.

Category A: Surface EEG signal recorded from 5 healthy volunteers in a relaxed awake state with eyes open.

Category B: EEG signal recorded from 5 healthy volunteers in a relaxed state with eyes closed.

Category C: Deep signals recorded from epileptic patients during the interval between seizures from inside the area that caused the seizure. (focal signals)

Category D: Deep recorded signals from epileptic patients during the intervals between seizures from outside the area that caused the seizure. (non-focal signals)

Category E: Signals recorded from epileptic seizures.

All EEG signals were recorded with the 128-channel system with common average voltage. Sampling frequency in this database is 173.61 Hz. According to the Nyquist Theorem, the maximum useful sampling frequency is half of the sampling frequency. Here we have:

$$\frac{f_s}{2} = \frac{173.61}{2} = 86.6 \text{ Hz} \quad (1)$$

Where f_s is the sampling frequency. The placement design of surface electrodes is related to the 20-10 global system, is shown in Fig. 1. Therefore, the electrodes were named as follows [10]:

FP1,FP2,F3,F4,C3,C4,P3,P4,F7,F8,T1,T2,T3,T5,T6,O1,O2,F2,P2

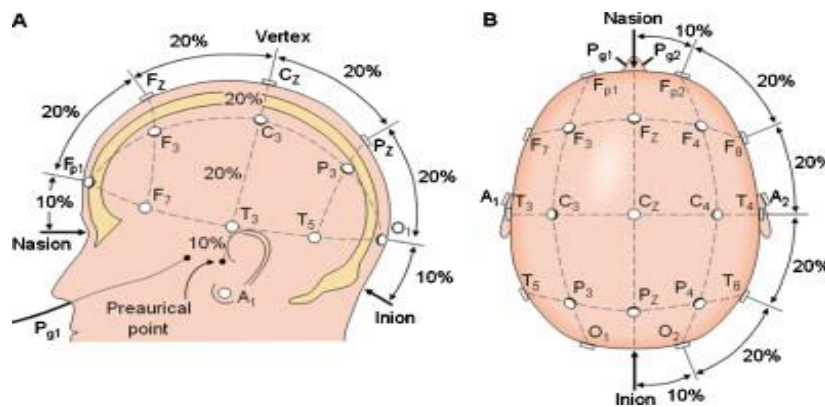


Figure. 1. The pattern of surface electrodes placement following that of the universal system 20-10.

The frontal lobe, temporal lobe, parietal lobe, central lobe, and occipital lobe were named F, T, P, C, and O, respectively [11.].The Fig. 2 describes the anatomy of the brain with different regions[12].

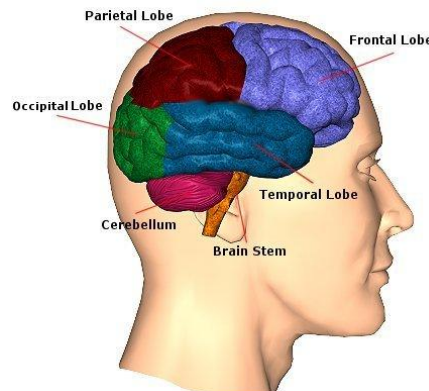


Figure. 2. Human brain structure.

3. METHODOLOGY

3.1. Wavelet Transform for Signal Analysis

Wavelet transform technique is used to decompose the signals and reconstruct the data accurately. rippling remodel technique could be a appropriate analytical tool for the Non Stationary signals analysis like encephalogram and it had been projected by Jean Morlet a French geologist in 1982 [2] It involves the breaking down of the brain signals into numerous shorter reads of bands as per demand. In distinct wavelet analysis, a multi-resolution description is employed to decompose a given signal $f(t)$ into progressively finer details supported 2 sets of basic functions [13] the wavelets and the scaling functions, as follows:

$$f(t) = \sum_{i=z} 2^{\frac{i}{2}} C_j(k) \varphi(2^j t - k) \sum_{j=0}^{j-1} \sum_{k=0}^{\infty} 2^j d_j \psi(2^j t - k) \quad (2)$$

Where functions $\varphi(t)$ and $\psi(t)$ are the basic scaling and mother wavelet respectively. Five sub-bands are obtained, namely Delta (0-4.05 Hz), Theta (4.05-8.1Hz), Alpha (8.1-12.15 Hz), Beta (12.15-32.5 Hz) and Gamma (>32.5 Hz) [14].

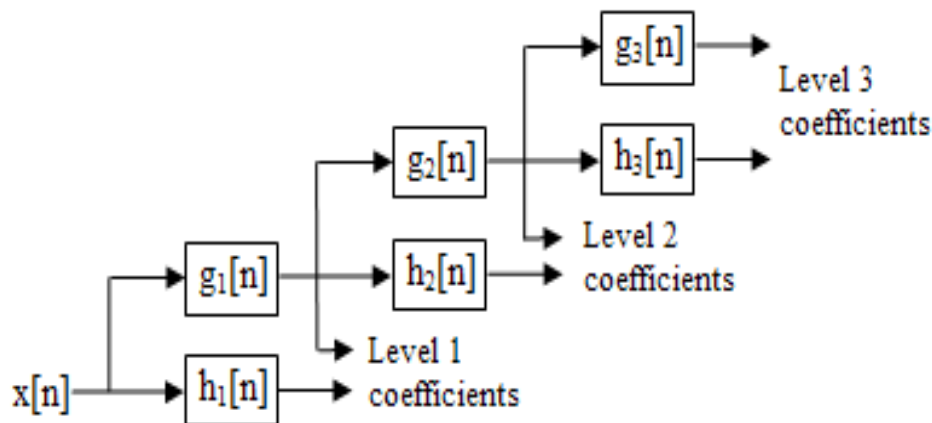


Figure. 3: Sub-band decomposition of DWT implementation; $h[n]$ is the highpass filter, $g[n]$ the low-pass filter.

The number of decomposition levels is chosen supported the dominant frequency parts of the signal. The amount square measure chosen such those components of the signal that correlates well with the frequencies necessary for classification of the signal square measure maintained within the riffle coefficients. Within the present study, since the encephalogram signals don't have any helpful frequency parts higher than 30 cycles/second, the amount of decomposition levels was chosen to be four. Thus, the encephalogram signals were rotten into details D1–D4 and one final approximation, A4. Usually, tests square measure performed with differing kinds of wavelets and also the one, which supplies most potency, is chosen for the actual application. The smoothing feature of the Daubechies riffle of order a pair of (db2) created it additional applicable to sight changes of encephalogram signals. Hence, the riffle coefficients were computed victimization the db4 within the present study. The projected methodology was applied on each knowledge set of encephalogram knowledge (Sets A and E).

3.2. Feature extraction

In this frammework have chosen the statistical parameters All the extracted features constitute the combined feature index $(CFI) = (F1, F2, F3, F4, F5, \dots, Fn)$, which is presented as an input to the ANN network. The features used in evaluating the performance of the proposed scheme are mean, standard deviation, median, entropy, kurtosis and skewness were calculated at each decomposition level starting from 01 to 04 for the normal and epilepsy categories of signals. The mathematical equations are represented as follows:

Mean μ

Mean are fundamental statistical attributes of a time series the arithmetic mean of a time series is the average expected value of that time series. In some cases, the mean value of a time series can be the operating point or working point of a physical system that generates the time series.

$$\mu = \frac{1}{N} \sum_{i=1}^N A_i \quad (3)$$

$$i = 1, 2, 3, 4, \dots$$

The mean indicated by μ . The Value in the signal X, by letting the index, i, run from 0 to 1. Then finish the calculation by dividing the sum by N. This is identical to the equation: $\mu = (X_0 + X_1 + X_2 + \dots + X_{N-1}) / N$.

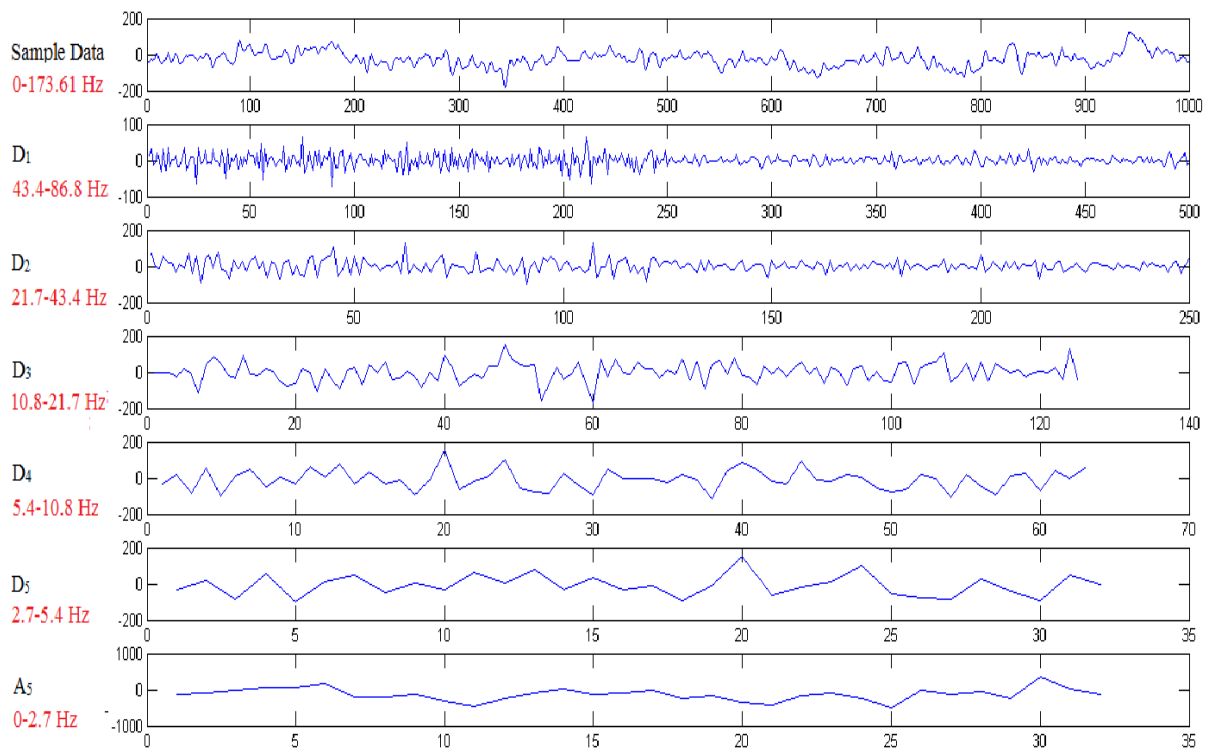


Figure 4. -Level wavelet decomposition of sample data (from set A) signals of 0-173.61 Hz. D1-D5 are details and A5 is the approximation. (For clear visibility only 1000 initial samples taken from 4097 samples of the sample data and axis are not equal on the sub-plots)

Standard Deviation σ

The standard deviation is similar to the average deviation except the averaging is done with power instead of amplitude. This is achieved by squaring each of the deviation before taking the average. To finish the square root is taken to compensate for the initial squaring. In equation from the standard deviation is calculation:

$$\sigma = \sqrt{\frac{1}{N} \sum_{i=1}^N (x_i - \mu)^2} \quad (4)$$

$$i = 1, 2, 3, 4, \dots$$

X is signal with mean μ , N is the number of sample and σ is standard deviation.

Kurtosis k

The kurtosis are higher-order statistical attributes of a time series. Kurtosis measures the peakedness of the probability density function (PDF) of a time series. A kurtosis value close to three indicates a Gaussian-like peakedness. PDFs with relatively sharp peaks have kurtosis greater than three. PDFs with relatively flat peaks have kurtosis less than three.

$$k = \frac{E(x - \mu)^4}{\sigma^4} \quad (5)$$

Where X is a signal, μ is the mean of x , σ is the standard deviation of X , and $E(t)$ represented the expected value of the quantity t . Kurtosis computes a sample version of this population value.

Skewness S

The skewness are higher-order statistical attributes of a time series. Skewness indicates the symmetry of the probability density function (PDF) of the amplitude of a time series. A time series with an equal number of large and small amplitude values has a skewness of zero. A time series with many small values and few large values is positively skewed and the skewness value is positive. A time series with many large values and few small values is negatively skewed and the skewness value is negative.

$$S = \frac{E(x - \mu)^3}{\sigma^3} \quad (6)$$

Where μ is the mean of signal x , σ is the standard deviation of x , and $E(t)$ represented the expected value of the quantity t . Skewness computes a sample version of this population value.

Entropy E

Entropy is a numerical measure of the randomness of a signal. Entropy can act as a feature and used to analyze psychological time series data such as EEG data. The Entropy can thus be calculated as:

$$E(s) = \sum_i E(s_i) \quad (7)$$

$$i = 1, 2, 3, 4, \dots$$

The E must be the an additive cost function such that $E(0) = 0$. Entropy is the statistical descriptor of the variability within the EEG signal and is a strong feature for epilepsy detection.

Median M

The median is a simple measure of central tendency. To find the median, we arrange the observations in order from smallest to largest value. If there is an odd number of observations, the median is the middle value. If there is an even number of observations, the median is the average of the two middle values

$$\bar{X} = \frac{\sum_{i=1}^n X_i}{n} \quad (8)$$

X refers to the entire set of the numbers. Median are more robust than arithmetic mean and geometric mean if the raw data does not contain significant outliers.

3.3. Classification

The applied mathematics options derived from DWT are applied to the classifiers. The main aim of the classifier is to spot, the brain disorder abnormality in EEG data by linear/non-linear mathematical approach. In proposed work, the classifiers used are Neural Network Analysis and k- nearest neighbour, to spot epileptic seizure EEG data for the individual and combined the applied mathematics options derived from DWT with a

special combination of data sets A with E. The performance of NNA and SVM classifiers is assessed with accuracy, sensitivity and specificity for the derived DWT based mostly applied mathematics options to detection the seizure abnormality. Using 30 parameters 80 non-epileptics and 80 epileptic for NNA, 100 non-epileptics and 100 epileptic for SVM cases taken from database described before are analyzed.

Classification using NNA

The performance of NNA classifiers is assessed with accuracy, sensitivity and specificity to detection the epileptic seizure abnormality. This task was performed using MATLAB 2015a. In this work Neural network pattern recognition was used for evaluating different states of EEG signals, such as healthy and epileptic states. Structure of Multilayer perceptron shown in figure. 5. In this work the dataset which is used from these data 75% data from set A and 75% data from set E is used for Training. For testing purpose 25% data is used. This selected data is used as input to the MLPNN Classifier which is used in this work.

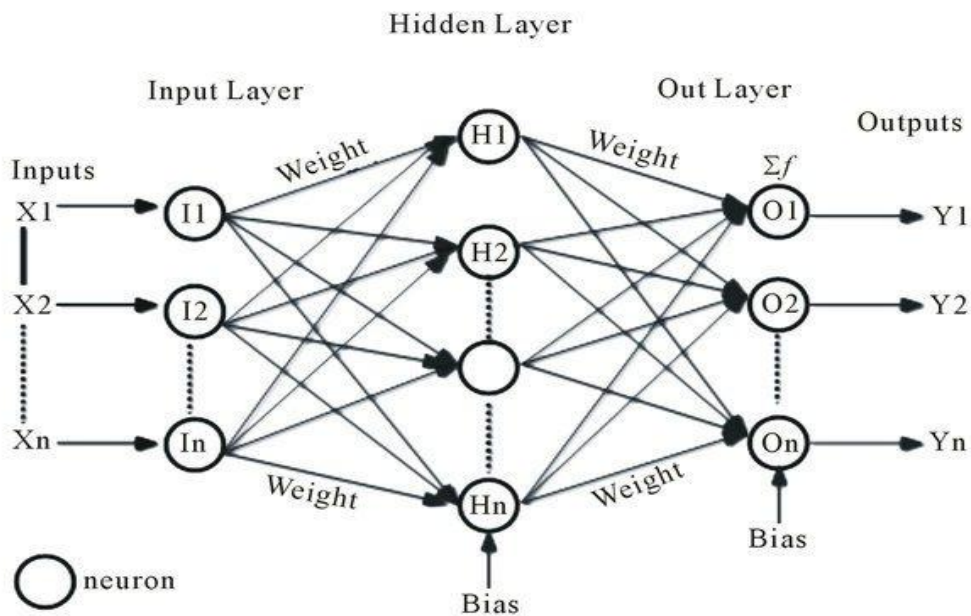


Figure 5. Multilayer perceptron.

The number of neurons in the input layer symbolizes the number of features presented to the network, followed by hidden layer with neurons which transforms the input into nonlinear combinations and passes the signals to the output layer (15). In our study, the number of neurons in the input layer is ten corresponding to CFI and the number of neurons in the output layer is three to classify three different classes.

The most difficult task is to pick the amount of neurons in hidden layer. In this framework a tendency to varied the numbers of hidden nodes to seek out out the design giving the higher performance with high accuracy. The framework technique by consistently enumerating all combinations of feature vectors and checking all completely different size CFIs for the optimality of the options.

Classification using SVM

The idea of SVM is originated from the idea of controlling the generalizing capabilities of machines for automation. The performance of a classifier must be generalized, i.e. it should perform well when it is applied for the data outside the training set. The notion of maximizing the margin between the support vectors is at the heart of the SVM classifier, in order to perform more accurately on unknown data [16,17] Consider the hyper-plane in (9):

$$W^T x + W_0 = 0 \quad (9)$$

The margin is the Euclidian distance $1/\|w\|$ between the two parallel hyper-planes (support vectors) described in (10):

$$W^T x + W_0 = 1, \text{ and } W^T x + W_0 = -1 \quad (10)$$

Let x_i are training points, with respective classes $y_i \in \{-1, 1\}$, $i=1, 2, \dots, N$ for a 2 class classification problem. The task is to optimize for minimum training error and maximum separating margin between hyper-planes of (10). SVM classifier solves this task by solving the optimization problem of (11):

$$\text{Minimize } L(W, W_0, \xi) = \frac{1}{2} \|W\|^2 + C \sum_{i=1}^N \xi_i \quad (11)$$

$$\text{Subjected } W^T x + W_0 \geq 1 - \xi_i, \quad \text{if } y_i \in 1$$

$$\text{And } W^T x + W_0 \leq 1 + \xi_i, \quad \text{if } y_i \in -1$$

$$\text{And } \xi_i \geq 0 \quad (12)$$

For the present work, involving two class classification (Epileptic seizure or not), we first learn the classifier equation (similar to (9)) by solving the optimization problem of (11) with constraints of (12), using half of the feature vectors from Matrixas training data. It is found that the entropy and kurtosis from all the five sub-bands are optimum for classification of EEG signals and it gives high performance accuracy.

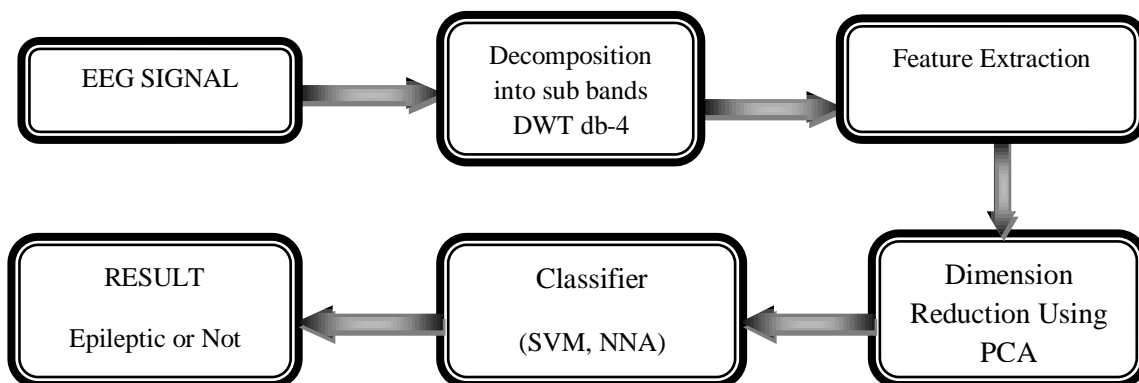


Figure.6 General block diagram for seizure classification

5. EXPERIMENTAL RESULT

In this process classification is done for ictal state (E) and other healthy state (A) and in order to measure the performance of the classifier, Sensitivity (TPR) and Specificity (TNR) were calculated and further total Accuracy will be calculated with the help of all above.

Sensitivity (TPR)

The sensitivity of a take a look at is its ability to see the patient cases properly. To estimate it, we should always calculate the proportion of true positive in patient cases [18].

Specificity (TNR)

The specificity of a test is its ability to determine the healthy cases correctly. To estimate it, we should calculate the proportion of true negative in healthy cases [18].

Accuracy

The accuracy of a check is its ability to differentiate the patient and healthy cases properly. To estimate the accuracy of a check, we must always calculate the proportion of true positive and true negative all together evaluated cases [18].

Equation given below describes the formula used for calculating Sensitivity and Specificity using:

TPR = True Positive Ratio, TNR = True Negative Ratio, TP = True Positive, TN = True negative, FP = False Positive, FN = False Negative.

Mathematically, this can be stated as:

$$\text{Sensitivity} = \text{TPR} = \frac{\text{TP}}{\text{TP} + \text{FN}} \times 100\%$$

$$\text{Specificity} = \text{TNR} = \frac{\text{TN}}{\text{TN} + \text{FP}} \times 100\%$$

$$\text{Accuracy} = \frac{\text{TP} + \text{TN}}{\text{TP} + \text{FP} + \text{TN} + \text{FN}} \times 100\%$$

		Predicted Class		
		Class	Yes	No
Actual Class	Yes		TP	FN
	No		FP	TN

Performance of NNA Classifier

Table 5.2: Confusion matrix for normal and epileptic detection

		Predicted Class		
		Class	Epileptic	Normal
Normal with Eye open and	Yes	80	0	
Epileptic classification	No	0	80	

The values obtained for performance measuring Parameters is shown in table. 5.3

Performance Table no 5.3

	Accuracy	Sensitivity	Specificity
Normal with Eye open and Epileptic classification	100%	100%	100%

Performance of SVM Classifier

Table 5.4: Confusion matrix for normal and epileptic detection

	Predicted Class		
	Class	Epileptic	Normal
Normal with Eye open and Epileptic classification	Yes	98	2
	No	0	100

The values obtained for performance measuring Parameters is shown in table. 5.3

Performance Table no 5.5

	Accuracy	Sensitivity	Specificity
Normal with Eye open and Epileptic classification	99%	98%	100%

6. CONCLUSION

An expert model was developed for detection of epilepsy on the background of EEG by using discrete wavelet transform and SVM and MLPNN classifiers. The feature like Mean, median, entropy, standard deviation, kurtosis, skewness was extracted from the EEG signal. The results have been shown that the proposed technique could attain a higher accuracy using SVM and MLPNN both the classifier for normal eyes open and epileptic seizure EEG data sets for all individual and combined statistical features derived from DWT for the detection of an epileptic seizure. The study of the proposed technique is evident from the other pattern recognition approaches considered by the researchers for different combination of data set A and D and we confirm that the NNA classifier achieves high accuracy with less computation time compare to SVM.

ACKNOWLEDGEMENTS

The authors are very much thankful to Dr. R. G. Andrzejak of University of Bonn, Germany, for providing permission to use the EEG data available in the public domain [9]. I owe a debt of gratitude to my project guide Dr. Arun Kumar, Associate Professor, Department of Electronics & Telecommunication Engineering, for his right orientation, invaluable knowledge. His critical judgment and review shaped this paper to add with a quality manuscript.

REFERENCES

- [1] Litt B Echauz, J. Prediction of epileptic seizures. The Lancet Neurology 2002;1: 22-30.

- [2] Subasi A, Erçelebi E. Classification of EEG signals using neural network and logistic regression. *Computer methods and programs in biomedicine* 2005;78:87-99.
- [3] Stein A.G, Eder H. G, Blum D. E, Drachev A, Fisher R. S. An automated drug delivery system for focal epilepsy. *Epilepsy research* 2000;39: 103-114.
- [4] Osorio I, Frei M. G. Real-time detection, quantification, warning, and control of epileptic seizures: The foundations for a scientific epileptology. *Epilepsy & Behavior* 2009;16: 391-396
- [5] Mormann F, Kreuz T, Andrzejak R. G, David P,Lehnertz K, Elger C. E. Epileptic seizures are preceded by a decrease in synchronization. *Epilepsy research* 2003;53: 173-185.
- [6] Iasemidis L. D. Epileptic seizure prediction and control. In: *IEEE 2003 Biomedical Engineering* ; pp. 549-558.
- [7] Tong S, Thakor N. V. *Quantitative EEG analysis methods and clinical applications*. Artech House ,2009.
- [8] Deburchgraeve W,Cherian P. J, De Vos M, Swarte R. M, Blok J. H, Visser G. H, Van Huffel S. Automated neonatal seizure detection mimicking a human observer reading EEG. *Clinical Neurophysiology* 2008;119: 2447-2454.
- [9] Andrzejak R. G, Lehnertz K, Mormann F, Rieke C, David P, Elger C. E. Indications of nonlinear deterministic and finite-dimensional structures in time series of brain electrical activity: Dependence on recording region and brain state. *Physical Review E* 2001;64: 061907.
- [10] Kumari, Pinki, and AbhishekVaish. "Brainwave based user identification system: A pilot study in robotics environment." *Robotics and Autonomous Systems* 65 (2015): 15-23.
- [11] Durka P. J. Adaptive time-frequency parametrization of epileptic spikes. *Physical Review E* 2004;69:051914.
- [12] Kumari, Pinki, and AbhishekVaish. "Feature-level fusion of mental task's brain signal for an efficient identification system." *Neural Computing and Applications*: 1-11.
- [13] C. S. Burrus, R. A. Gopinath, & H. Guo (1998). *Introduction to wavelets and wavelet transforms: A primer*. Prentice-Hall, Upper Saddle River, NJ.
- [14] Mandeep Singh & Sunpreet Kaur (2012).. *Epilepsy, Frequency Band Separation for Epilepsy Detection Using EEG*, *International Journal of Information Technology & Knowledge Management*, Vol 6, No.1.
- [15] Claude Roberta, Jean-Francois Gaudy & Aime' Limogea (2002) "Electroencephalogram processing using neural networks", *Clinical Neurophysiology* 113, pp.694-701.
- [16] S. Theodoridis, and K. Koutroumbas. *Pattern Recognition*. 4th Ed., Elsevier - Academic Press, 2009.
- [17] P. S. Sastry. "An introduction to Support Vector Machines". Chapter in J.C. Misra (Ed), *computing and information sciences: Recent Trends*. Narosa Publishing House, New Delhi 2003.
- [18] Alireza Baratloo, Mostafa Hosseini, Ahmmed Negida & Gehad El Ashal (2015). Simple Definition and Calculation of Accuracy, Sensitivity and Specificity. Volume 4 No.2, pp. 48-49.